

Accepted Manuscript

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PII: S0040-6090(17)30855-6
DOI: doi:[10.1016/j.tsf.2017.11.019](https://doi.org/10.1016/j.tsf.2017.11.019)
Reference: TSF 36351
To appear in: *Thin Solid Films*
Received date: 17 May 2017
Revised date: 29 October 2017
Accepted date: 13 November 2017

Please cite this article as: Hiroto Oomae, Takahito Eguchi, Kunihiko Tanaka, Misao Yamane, Naofumi Ohtsu , X-ray diffraction and X-ray photoelectron spectroscopy characterization of sulfurized tin thin films deposited by thermal evaporation. The address for the corresponding author was captured as affiliation for all authors. Please check if appropriate. Tsf(2017), doi:[10.1016/j.tsf.2017.11.019](https://doi.org/10.1016/j.tsf.2017.11.019)

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characterization of sulfurized tin thin films deposited by thermal
evaporation

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